

<i>Notice of References Cited</i>	Application/Control No. 10/580,575	Applicant(s)/Patent Under Reexamination FUJINO ET AL.	
	Examiner DENNIS HEYER	Art Unit 4121	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0286133	12-2006	Fujino et al.	424/401
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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